

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/601,061	WEI ET AL.	
Examiner	Art Unit	
Adolf Berhane	2838	

SEARCHED					
Class	Subclass	Date	Examiner		
363	34				
	37				
	39				
	40				
	47				
	48	7/7/2005	АВ		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
363	34				
	39	7/7/2005	AB		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		